

GP1S036HEZ

Phototransistor Output, Transmissive Photointerrupter with Tilt Direction (4-direction) **Detecting**

■ Description

GP1S36J0000F is a compact-package, phototransistor output, transmissive photointerrupter, with opposing emitter and detector in a molding that provides a ball built-in case sensing. The compact package series is a result of unique technology combing transfer and injection molding.

This is a 2-phase output device, suitable for detection of the position (4 direction).

■ Features

- 1. Transmissive with phototransistor output
- 2. Highlights:
 - Built-in a ball (2 phase output)
 - Compact
 - PWB mounting type
 - · 4-direction detection
- 3. Lead free and RoHS directive compliant

■Agency approvals/Compliance

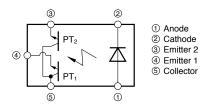
1. Compliant with RoHS directive

■Applications

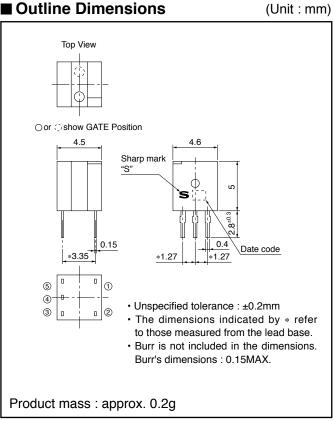
- 1. General purpose detection of device direction.
- 2. Example: Camera, DSC, Camcorder, Robot



■ Internal Connection Diagram



■ Outline Dimensions



Plating material: SnCu (Cu: TYP. 2%)



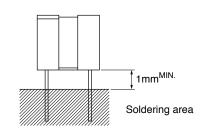
Date code (2 digit)							
1st	digit	2nd digit					
Year of p	production	Month of production					
A.D.	Mark	Month	Mark				
2000	0	1	1				
2001	1	2	2				
2002	2	3	3				
2003	3	4	4				
2004	4	5	5				
2005	5	6	6				
2006	6	7	7				
2007	7	8	8				
2008	8	9	9				
2009	9	10	X				
2010	0	11	Y				
:	:	12	Z				

repeats in a 10 year cycle

Country of origin Japan, China



■ Absolute Maximum Ratings $(T_a=25^{\circ}C)$ Parameter Symbol Rating Unit 50 Forward current I_{F} mA Reverse voltage 6 V Input V_R P 75 Power dissipation mW $V_{CE1O} \\$ 35 V Collector-emitter voltage $V_{CE2O} \\$ $V_{E1CO} \\$ Emitter-collector voltage 6 V Output V_{E2CO} 20 Collector current I_{C} mACollector power dissipation P_{C} 75 mWTotal power dissipation 100 mW P_{tot} T_{opr} -25 to +85 °C Operating temperature $T_{\underline{s}\underline{t}\underline{g}}$ Storage temperature -40 to +100 °C *1Soldering temperature 260 °C $T_{sol} \\$



■ Electro-optical Characteristics

 $(T_a=25^{\circ}C)$

	-						,			
	Parameter			Condition	MIN.	TYP.	MAX.	Unit		
Innut	Forward voltage		Forward voltage		V_{F}	I _F =20mA	_	1.2	1.4	V
Input	Reverse current		I_R	$V_R=3V$	_	_	10	μΑ		
*3Output	Dark current		I_{CEO}	$V_{CE}=20V$	_	_	100	nA		
	Collector current		I_{C}	$V_{CE}=5V$, $I_{F}=5mA$	55	_	300	μΑ		
*3Transfer	*4Leak current		I _{LEAK}	$V_{CE}=5V$, $I_{F}=5mA$	_	_	17	μΑ		
charac-	Collector-emitter saturation voltage		$V_{\text{CE(sat)}}$	$I_{F}=10\text{mA}, I_{C}=55\mu\text{A}$	_	_	0.4	V		
teristics	teristics Passages time		t _r	V 5V I 100 A D 11co	_	50	150	μs		
Kespe	Kesponse time	Response time Fall time		$V_{CE}=5V$, $I_{C}=100\mu A$, $R_{L}=1k\Omega$	_	50	150	μs		

 $^{{}^{*}3}$ Output and coupling characteristics are common to the both phototransistors.

^{*1} For MAX. 5s

^{*4} Characteristics except leak current is measured at θ =180°, ϕ =0°.

Leak current is the output current of transistor when θ =+90° or -90°, ϕ =0° and I_C=OFF.



■ Absolute Maximum Ratings $(I_F=5mA, V_{CC}=5V, \phi \leq \pm 5)$

θ	0°	\rightarrow	30°	1	60°	\rightarrow	120°	\rightarrow	150°	^	210°
I_{C1}	OFF				Indefinite			ON			
I_{C2}	Ol	FF	In	defini	te		ON				Indefinite

θ	\rightarrow	240°	→	300°	\rightarrow	330°	~	360°
I_{C1}	ON		Indefinite			OFF		
I_{C2}	Inde	finite	OFF					

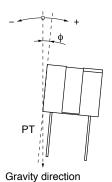
 I_{C1} : Output current of phototransistors PT_1 I_{C2} : Output current of phototransistors PT_2

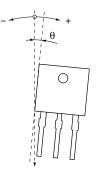
θ: Device condition: Refer to the figure
 φ: Device condition: Refer to the figure

ON :Output current of phototransistors : $55\mu A$ or more OFF : Output current of phototransistors : $17\mu A$ or less

* Output of ON/OFF is under the condition that the device is in stationary state.

Device state diagram

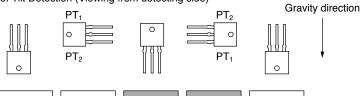




Gravity direction (Viewing from detecting side)

■ Supplement

Principle of Tilt Detection (Viewing from detecting side)



PT₁ output

PT₂ output











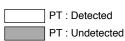




Fig.1 Forward Current vs.

Ambient Temperature

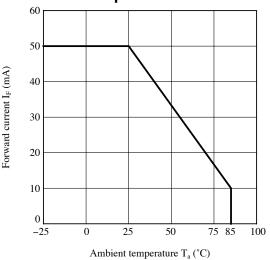


Fig.3 Forward Current vs. Forward Voltage

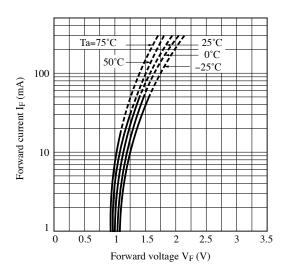


Fig.5 Collector Current vs.
Collector-emitter Voltage

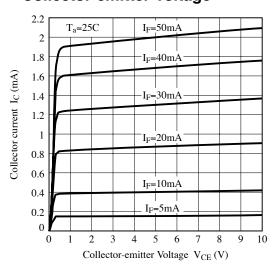


Fig.2 Power Dissipation vs. Ambient Temperature

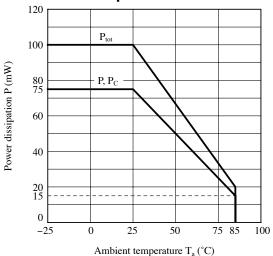


Fig.4 Collector Current vs. Forward Current

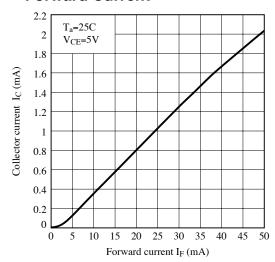


Fig.6 Relative Collector Current vs.
Ambient Temperature

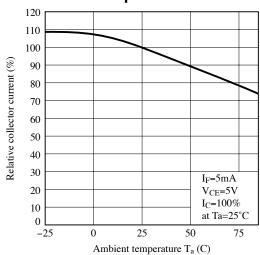




Fig.7 Collector-emitter Saturation Voltage vs.
Ambient Temperature

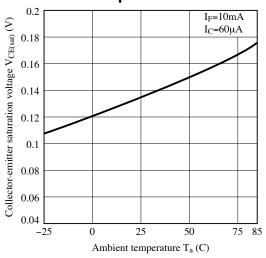


Fig.8 Response Time vs. Load Resistance

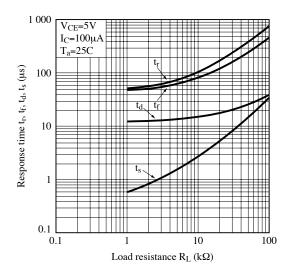


Fig.9 Collector Dark Current vs. Ambient Temperature

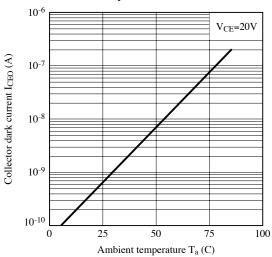
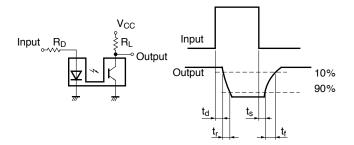


Fig.10 Test Circuit for Response Time



Remarks: Please be aware that all data in the graph are just for reference and not for guarantee.



■ Design Considerations

Design guide

1) Prevention of malfunction

To prevent photointerrupter from faulty operation caused by external light, do not set the detecting face to the external light.

Please confirm that there is no mis-operation by magnetic field in use, for prevention of mis-operation by magnetic field.

Please don't let the device put in change of temperature that makes dew for prevention of mis-operation by dew.

If the device is put in the change of temperature which makes dew, please leave the device for enough time in the constant temperature for use.

This product is not designed against irradiation and incorporates non-coherent IRED.

Degradation

In general, the emission of the IRED used in photointerrupter will degrade over time.

In the case of long term operation, please take the general IRED degradation (50% degradation over 5 years) into the design consideration.

Parts

This product is assembled using the below parts.

Photodetector (qty.: 1)

Category	Material	Maximum Sensitivity wavelength (nm)	Sensitivity wavelength (nm)	Response time (µs)	
Phototransistor	Silicon (Si)	800	700 to 1 200	12	

• Photo emitter (qty.: 1)

Category	Material	Maximum light emitting wavelength (nm)	I/O Frequency (MHz)	
Infrared emitting diode (non-coherent)	Gallium arsenide (GaAs)	950	0.3	

Material

Case	Lead frame	Lead frame plating	Packing case	Metal ball
Black polyphenylene sulfide resin (UL94 V-0)	42Alloy	SnCu plating	Polycarbonate	Fe



■ Manufacturing Guidelines

Soldering Method

Flow Soldering:

Soldering should be completed below 260°C and within 5 s.

Please solder within one time.

Soldering area is 1mm or more away from the bottom of housing.

Please take care not to let any external force exert on lead pins.

Please don't do soldering with preheating, and please don't do soldering by reflow.

Lead pin

Lead terminals of this product are tin copper alloy plated. Before usage, please evaluate solderability with actual conditions and confirm. And the uniformity in color for the lead terminals are not specified.

Other notice

Please test the soldering method in actual condition and make sure the soldering works fine, since the impact on the junction between the device and PCB varies depending on the tooling and soldering conditions.

Cleaning instructions

The device shall not be washed with washing material, for there is possibility to remain washing material in internal space of this transmissive type photointerrupter.

Presence of ODC

This product shall not contain the following materials.

And they are not used in the production process for this product.

Regulation substances: CFCs, Halon, Carbon tetrachloride, 1.1.1-Trichloroethane (Methylchloroform)

Specific brominated flame retardants such as the PBBOs and PBBs are not used in this product at all.

This product shall not contain the following materials banned in the RoHS Directive (2002/95/EC).

•Lead, Mercury, Cadmium, Hexavalent chromium, Polybrominated biphenyls (PBB), Polybrominated diphenyl ethers (PBDE).



■ Package specification

● Sleeve package

Package materials

Sleeve : Polystyrene

Stopper: Styrene-Elastomer

Package method

MAX. 40 pcs. of products shall be packaged in a sleeve. Both ends shall be closed by tabbed and tabless stoppers.

MAX. 50 sleeves in one case.



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